Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/605,785	LEE ET AL.	
Examiner	Art Unit	
Ryan Hsu	3714	

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Class	Subclass	Date	Examiner
473	202	5/9/2006	RH
473	198, 201	5/9/2006	RH
473	221-226	5/9/2006	RH
473	231-233	5/9/2006	RH
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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